TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π–MOSV)

2SK2598

Chopper Regulator, DC-DC Converter and Motor Drive Applications

• Low drain-source ON resistance : $RDS(ON) = 0.18 \Omega \text{ (typ.)}$

• High forward transfer admittance $: |Y_{fs}| = 13 \text{ S (typ.)}$ • Low leakage current $: IDSS = 100 \mu A \text{ (max) (VDS} = 250 \text{ V)}$

• Enhancement-mode : $V_{th} = 1.5 \sim 3.5 \text{ V (V}_{DS} = 10 \text{ V, I}_{D} = 1 \text{ mA})$

Maximum Ratings (Ta = 25°C)

Characteris	stics	Symbol	Rating	Unit	
Drain-source voltage		V_{DSS}	250	V	
Drain-gate voltage (Ro	_{SS} = 20 kΩ)	V_{DGR}	250	V	
Gate-source voltage		V _{GSS}	±20	V	
Drain current	DC (Note 1)	I _D	13	Α	
	Pulse (Note 1)	I _{DP}	52	A	
Drain power dissipation	n (Tc = 25°C)	P _D	60	W	
Single pulse avalanche energy (Note 2)		E _{AS}	148	mJ	
Avalanche current		I _{AR}	13	Α	
Repetitive avalanche energy (Note 3)		E _{AR}	6	mJ	
Channel temperature		T _{ch}	150	°C	
Storage temperature range		T _{stg}	-55~150	°C	

Thermal Characteristics

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to case	R _{th (ch-c)}	2.08	°C/W
Thermal resistance, channel to ambient	R _{th (ch-a)}	83.3	°C/W

Note 1: Please use devices on condition that the channel temperature is below 150°C.

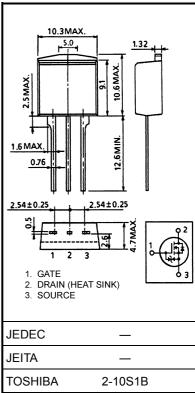
Note 2: V_{DD} = 50 V, T_{ch} = 25°C (initial), L = 1.48 mH, R_G = 25 Ω , I_{AR} = 13 A

Note 3: Repetitive rating: Pulse width limited by maximum channel temperature

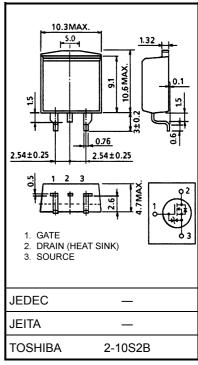
This transistor is an electrostatic sensitive device.

Please handle with caution.

Unit: mm



Weight: 1.5 g (typ.)



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Electrical Characteristics (Ta = 25°C)

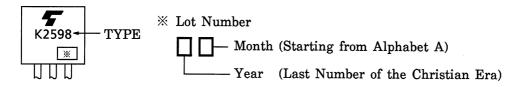
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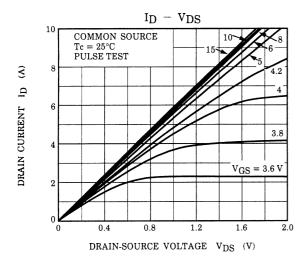
Charac	cteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage cu	ırrent	I _{GSS}	V _{GS} = ±16 V, V _{DS} = 0 V	_	_	±10	μΑ
Drain cut-off cu	rrent	I _{DSS}	V _{DS} = 250 V, V _{GS} = 0 V	_	_	100	μΑ
Drain-source br	eakdown voltage	V _{(BR) DSS}	I _D = 10 mA, V _{GS} = 0 V	200	_	_	V
Gate threshold	voltage	V _{th}	V _{DS} = 10 V, I _D = 1 mA	1.5	_	3.5	V
Drain-source O	N resistance	R _{DS} (ON)	V _{GS} = 10 V, I _D = 6.5 A	-	0.18	0.25	Ω
Forward transfe	r admittance	Y _{fs}	V _{DS} = 10 V, I _D = 6.5 A	6	13	_	S
Input capacitano	ce	C _{iss}			1800	_	
Reverse transfer capacitance		C _{rss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz		130	_	pF
Output capacitance		Coss			500	-	
Switching time	Rise time	t _r	$V_{GS} = 0 \text{ V}$ $V_{GS} = 0 \text{ V}$ $V_{DD} = 130 \text{ V}$	_	15	_	
	Turn-on time	t _{on}		_	25	-	ns
	Fall time	t _f		_	10	-	115
	Turn-off time	t _{off}	Duty $\leq 1\%$, $t_{\rm w} = 10 \mu{\rm s}$	_	70	_	
Total gate charge (Gate-source plus gate-drain)		Qg			40		
Gate-source charge		Q _{gs}	$V_{DD} \approx 200 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 13 \text{ A}$		25	_	nC
Gate-drain ("miller") charge		Q _{gd}			15	_	

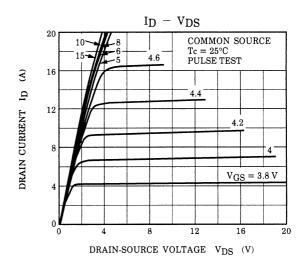
Source-Drain Ratings and Characteristics (Ta = 25°C)

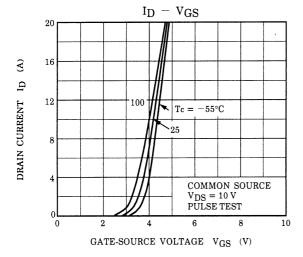
Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Continuous drain reverse current (Note 1)	I _{DR}	_	-	_	13	Α
Pulse drain reverse current (Note 1)	I _{DRP}	_		_	52	Α
Forward voltage (diode)	V _{DSF}	I _{DR} = 13 A, V _{GS} = 0 V	-	_	-2.0	V
Reverse recovery time	t _{rr}	I _{DR} = 13 A, V _{GS} = 0 V		260		ns
Reverse recovery charge	Q _{rr}	dl _{DR} / dt = 100 A / μs		0.3	_	μC

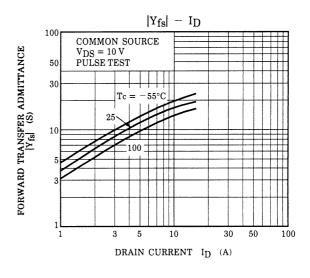
Marking

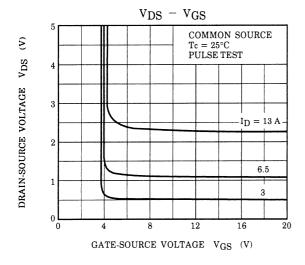


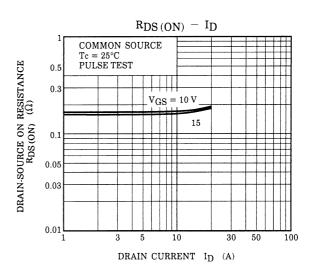




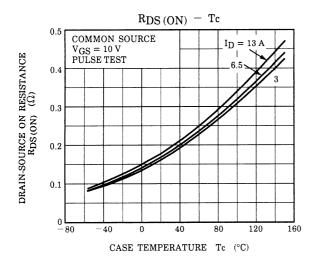


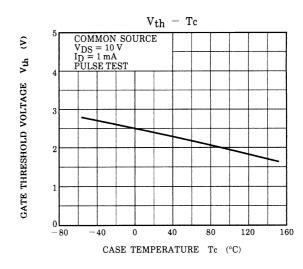


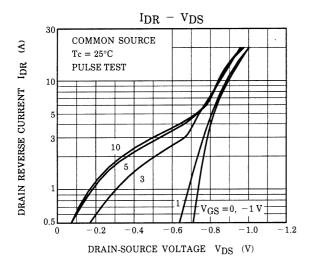


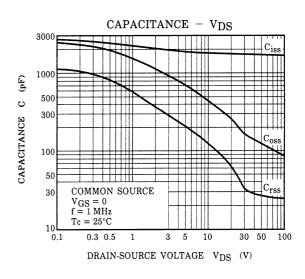


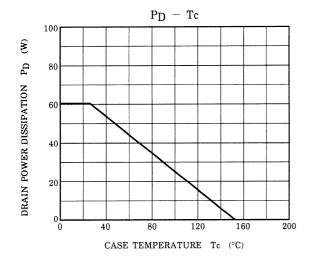
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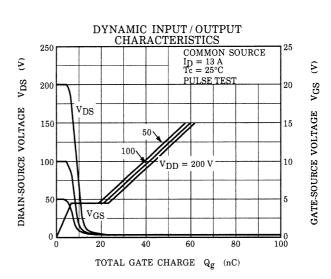




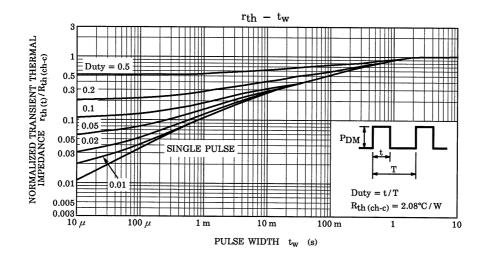


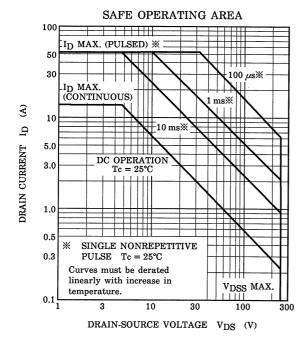


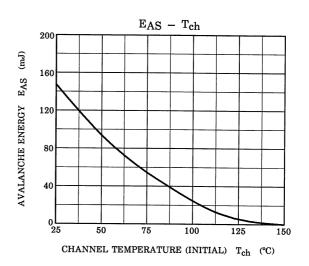


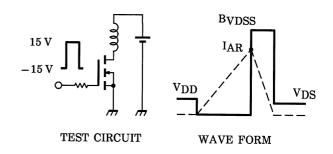


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$$\begin{aligned} &R_G = 25~\Omega \\ &V_{DD} = 50~V,~L = 1.48~mH \end{aligned} \qquad EAS = \frac{1}{2} \cdot L \cdot I^2 \cdot \left(\frac{BVDSS}{BVDSS - VDD} \right) \end{aligned}$$

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